

Notice of References Cited	Application/Control No. 10/587,948		Applicant(s)/Patent Under Reexamination DEKKER ET AL.	
	Examiner Jennifer Y. Cho		Art Unit 1621	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0241098	12-2004	Labourdette et al.	424/040
*	B	US-2002/0031504	03-2002	BEUDEKER, ROBERT FRANCISCUS	424/94.1
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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